

<b>Notice of References Cited</b>	Application/Control No. 10/592,948		Applicant(s)/Patent Under Reexamination SUWA ET AL.	
	Examiner Nathan W. Ha		Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,205,613	04-2007	Fjelstad et al.	257/355
*	C	US-6,995,322	02-2006	Chan et al.	174/262
*	D	US-6,987,314	01-2006	Yoshida et al.	257/698
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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